

Search Notes

Application/Control No.

10/773,269

Examiner

Sophia S. Chen

Applicant(s)/Patent under
Reexamination

YOSHIDA, NARUTAKA

Art Unit

2852

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|-------------------------------------|-----------|----------|
| 399 | 43, 44, 66, 67, 162, 302, 303 | 10/3/2005 | SC |
| 399 | 308 | 10/3/2005 | SC |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|---|-----------|------|
| 399/159, 313, 329, 352 (text search only - see search history printout) | 10/3/2005 | SC |
| EAST (USPAT, US-PGPUB, USOCR, EPO, JPO, DERWENT, IBM_TDB) - See search history printout | 10/3/2005 | SC |
| EAST (EPO, JPO) - See search history printout | 10/3/2005 | SC |
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